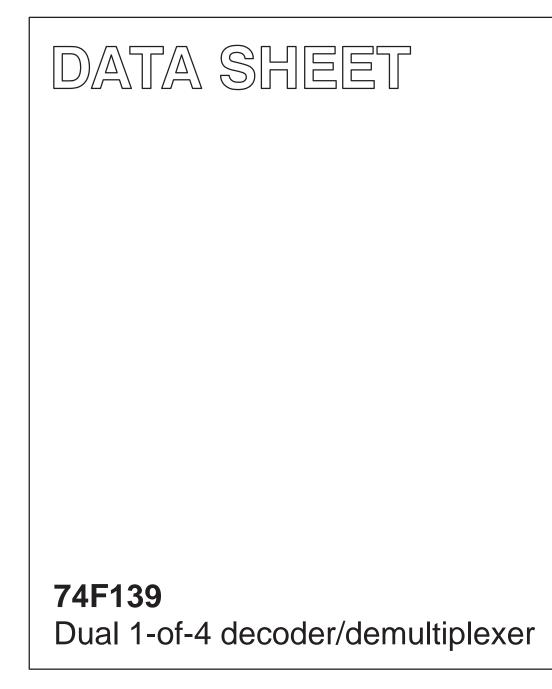
INTEGRATED CIRCUITS



Product specification

1990 Feb 23

IC15 Data Handbook



HILIP

Philips Semiconductors

74F139

FEATURES

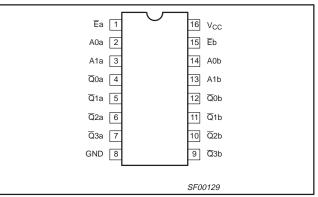
- Demultiplexing capability
- Two independent 1-of-4 decoders
- Multifunction capability

DESCRIPTION

The 74F139 is a high speed, dual 1-of-4 decoder/demultiplexer. This device has two independent decoders, each accepting two binary weighted inputs (A0n, A1n) and providing four mutually exclusive active-Low outputs ($\overline{Q}0n-\overline{Q}3n$). Each decoder has an active-Low Enable (\overline{E}). When \overline{E} is High, every output is forced High. The Enable can be used as the Data input for a 1-of-4 demultiplexer application.

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F139	5.3ns	13mA

PIN CONFIGURATION



ORDERING INFORMATION

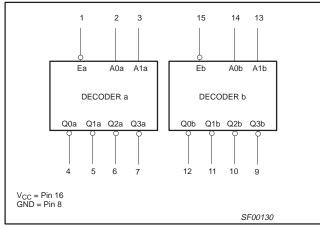
DESCRIPTION	$\begin{array}{l} \text{COMMERCIAL RANGE} \\ \text{V}_{\text{CC}} = 5\text{V} \pm 10\%, \\ \text{T}_{\text{amb}} = 0^{\circ}\text{C to} + 70^{\circ}\text{C} \end{array}$	PKG DWG #
16-pin plastic DIP	N74F139N	SOT38-4
16-pin plastic SO	N74F139D	SOT109-1

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

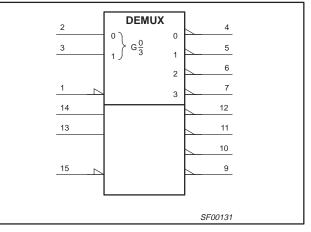
PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
Ana, Anb	Address inputs	1.0/1.0	20µA/0.6mA
Ēa, Ēb	Enable inputs (active Low)	1.0/1.0	20µA/0.6mA
Q0n–Q3n	Data outputs (active Low)	50/33	1.0mA/20mA

NOTE: One (1.0) FAST unit load is defined as: 20µA in the High state and 0.6mA in the Low state.

LOGIC SYMBOL

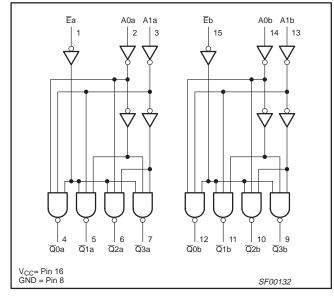


IEC/IEEE SYMBOL



74F139

LOGIC DIAGRAM



FUNCTION TABLE

	INPUTS			OUT	PUTS	
Ē	A0	A1	<u>Q</u> 0	<u>Q</u> 1	<u>Q</u> 2	<u>Q</u> 3
н	Х	Х	Н	Н	Н	Н
L	L	L	L	н	н	Н
L	н	L	н	L	н	Н
L	L	н	н	Н	L	н
L	н	Н	н	Н	Н	L

NOTES:

H = High voltage level L = Low voltage level

X = Don't care

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limits set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V _{CC}	Supply voltage	-0.5 to +7.0	V
V _{IN}	Input voltage	-0.5 to +7.0	V
I _{IN}	Input current	-30 to +5	mA
V _{OUT}	Voltage applied to output in High output state	–0.5 to +V _{CC}	V
I _{OUT}	Current applied to output in Low output state	40	mA
T _{amb}	Operating free-air temperature range	0 to +70	°C
T _{stg}	Storage temperature range	-65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER		LIMITS		
STMBOL	PARAMETER	MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage	4.5	5.0	5.5	V
V _{IH}	High-level input voltage	2.0			V
V _{IL}	Low-level input voltage			0.8	V
I _{IK}	Input clamp current			-18	mA
I _{OH}	High-level output current			-1	mA
I _{OL}	Low-level output current			20	mA
T _{amb}	Operating free-air temperature range	0		+70	°C

74F139

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

					LIMITS			
SYMBOL	PARAMETER	PARAMETER TEST CONDITIONS ¹				MAX	UNIT	
Maria	High lovel output voltage	$V_{CC} = MIN, V_{IL} = MAX$	±10%V _{CC}	2.5			V	
V _{OH}	High-level output voltage	$V_{IH} = MIN, I_{OH} = MAX$	±5%V _{CC}	2.7	3.4		V	
M	Low-level output voltage	$V_{CC} = MIN, V_{IL} = MAX$	$\pm 10\% V_{CC}$		0.30	0.50	V	
V _{OL}	Low-level output voltage	$V_{IH} = MIN, I_{OL} = MAX$	±5%V _{CC}		0.30	0.50	V	
V _{IK}	Input clamp voltage	$V_{CC} = MIN, I_I = I_{IK}$	$V_{CC} = MIN, I_I = I_{IK}$			-1.2	V	
l _l	Input current at maximum input voltage	$V_{CC} = MAX, V_I = 7.0V$				100	μΑ	
I _{IH}	High-level input current	$V_{CC} = MAX, V_I = 2.7V$				20	μΑ	
I _{ILL}	Low-level input current	$V_{CC} = MAX, V_I = 0.5V$				-0.6	mA	
I _{OS}	Short-circuit output current ³	$V_{CC} = MAX$		-60		-150	mA	
I _{CC}	Supply current (total)	$V_{CC} = MAX$			13	20	mA	

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

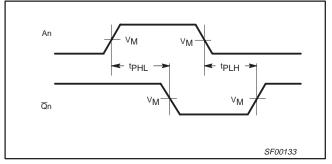
2. All typical values are at $V_{CC} = 5V$, $T_{amb} = 25^{\circ}C$. 3. Not more than one output should be shorted at a time. For testing I_{OS} , the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

AC ELECTRICAL CHARACTERISTICS

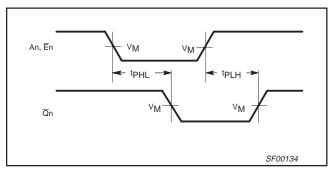
					LIMIT	S		
SYMBOL	PARAMETER	TEST CONDITION	Ta	ˈ _{CC} = +5.0 . _{mb} = +25° i0pF, R _L =	C	V _{CC} = +5. T _{amb} = 0°C C _L = 50pF,	C to +70°C	UNIT
			MIN	ТҮР	MAX	MIN	MAX	
t _{PLH} t _{PHL}	Propagation delay A0 ir A1 to Qna, Qnb	Waveform 1, 2	3.5 4.0	5.3 6.1	7.0 8.0	3.0 4.0	8.0 9.0	ns
t _{PLH} t _{PHL}	Propagation delay En to Qna, Qnb	Waveform 2	3.5 3.0	5.4 4.7	7.0 6.5	3.5 3.0	8.0 7.5	ns

AC WAVEFORMS

For all waveforms, $V_M = 1.5V$



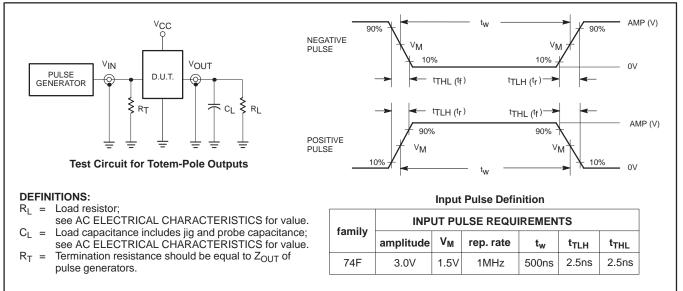
Waveform 1. Propagation Delay for Inverting Outputs



Waveform 2. Propagation Delay for Non-Inverting Outputs

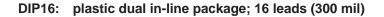
74F139

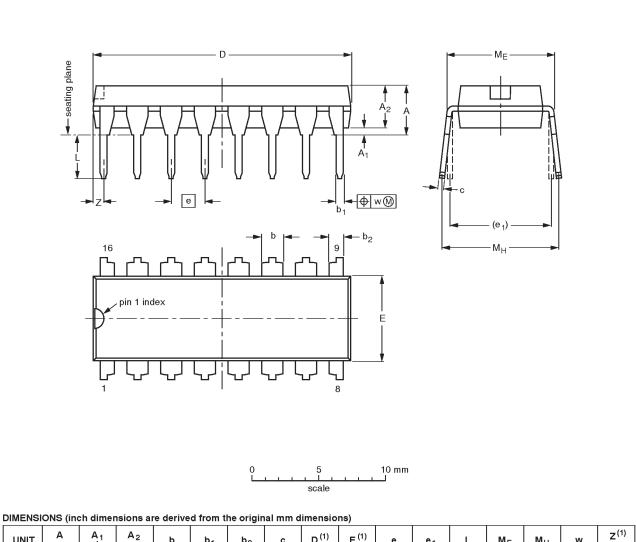
TEST CIRCUIT AND WAVEFORMS



SF00006

Dual 1-of-4 decoder/demultiplexer





UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	b ₂	c	D ⁽¹⁾	E ⁽¹⁾	е	e ₁	L	ME	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	1.25 0.85	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	0.76
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.049 0.033	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.030

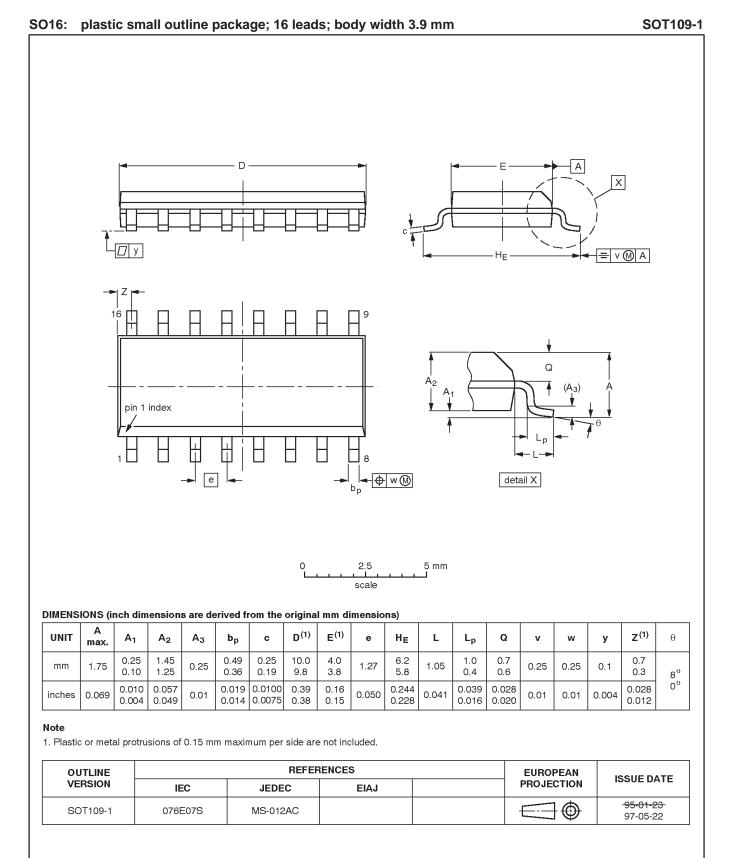
Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT38-4					-92-11-17 95-01-14

74F139

Dual 1-of-4 decoder/demultiplexer



Dual 1-of-4 decoder/demultiplexer

74F139

Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

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print code

Document order number:

Date of release: 10-98 9397-750-05077

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